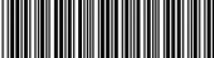


<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/579,971	KAWAMURA ET AL.	
				Examiner	Art Unit	
				Sikyin Ip	1793	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
148	420			EAST	1/19/2009	
420	405					
	406					
	411					
412		1/19/2009	SI	eDan inventor names searched	1/21/2009	SI
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			